



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Paul H. Shelley, et al. Applicant:

Attorney Docket No. BOEI-1-1194

Serial No.:

10/653,014

Group Art Unit:

2878

Filing Date: August 28, 2003

Examiner:

Title:

MEASUREMENT OF METAL POLISH QUALITY

INFORMATION DISCLOSURE STATEMENT

MAIL STOP AMENDMENT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sirs:

Pursuant to 37 C.F.R. § 1.56 and in accordance with 37 C.F.R. §§1.97-1.98, information related to the above-identified application is hereby disclosed. Inclusion of information in this statement is not to be construed as an admission that this information is material as that term is defined in 37 C.F.R. § 1.56(b).

In accordance with §1.97(b), since this Information Disclosure Statement is being filed either within three months of the filing date of the above-identified application, within three months of the date of entry into the national stage of the above identified application as set forth in §1.491, or before the mailing date of a first Office Action on the merits of the above-identified application, no additional fee is required.

The relevant publications are listed on the attached Form PTO-1449. In accordance with 37 CFR § 1.98(a)(2)(i), copies of U.S. references listed on the attached Form PTO-1449 are not If the examiner requires copies of any of the U.S. references it is hereby requested enclosed. that the examiner notify the undersigned accordingly. Copies of all other references are enclosed.

Respectfully submitted,

BLACK LOWE & GRAHAMPLLC

Mark S. Beaufait Registration No. 48,529 Direct Dial: 206.464.1380

MAIL CERTIFICATE

I hereby certify that this communication is being deposited with the United States Postal Service via first class mail under 37 C.F.R. § 1.08 on the date indicated below addressed to: MAIL STOP AMENDMENT, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT

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| Application Number | 10/653,014 | | | | |
| Filing Date | August 28, 2003 | | | | |
| First Named Inventor | Paul H. Shelley | | | | |
| Group Art Unit | 2878 | | | | |
| Examiner Name | | | | | |
| Attorney Docket Number | BOEI-1-1194 | | | | |

U.S. PATENT DOCUMENTS

Sheet

| | Cite No.1 | U.S. Patent Doc | ument | | |
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Examiner Date Signature Considered

| INFORMATION DISCLOSURE STATEMENT BY APPLICANT | | | | | Complete if Known | | | | |
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| | | | | ANT | First Named Inventor | Paul H. Shelley | | | |
| | | | | | Group Art Unit | 2878 | | | |
| | | | | | Examiner Name | - | | | |
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1. Applicant's unique citation designation number (optional). 2. Applicant is to place a check mark here if English language Translation is attached.

This collection of information is required by 37CFR 1.97 and 1.98. The information is required to obtain or retain a benefit by the public which is to file (and by the USPTO to process) an application. Confidentiality is governed by 35 U.S.C. 122 and 37 CFR 1.14. This collection is estimated to take 2 hours to complete including gathering, preparing and submitting the completed application form to the USPTO. Time will vary depending upon the individual case. Any comments on the amount of time you require to complete this form and/or suggestions for reducing this burden, should be sent to the Chief Information Officer, U.S. Patent and Trademark Office, U.S. Department of Commerce, P.O. Box 1450, Alexandria, VA 22315-1450. DO NOT SEND FEES OR COMPLETED FORMSTO THIS ADDRESS. SEND TO: Commissioner of Patents, P.O. Box 1450, Alexandria, VA 22315-1450.